Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/743,559	DUFFEK ET AL.
Examiner	Art Unit
Michael A. Friedhofer	2832

	SEAR	CHED	
····	JEAN	OTILD	·
Class	Subclass	Date	Examiner
. 200	43.17, 61.85,522, 332.2	6/10/2005	MAF
		,	
*			
			,

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
-				

	DATE	EXMR
,		
	,	
İ		